

<b>Notice of References Cited</b>	Application/Control No. 10/585,358		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Fred M. Teskin		Art Unit 1796	Page 1 of 1

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*	B	US-5,629,398	05-1997	Okamoto et al.	526/281
*	C	US-2005/0085606	04-2005	Yoon et al.	526/282
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	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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	U	
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